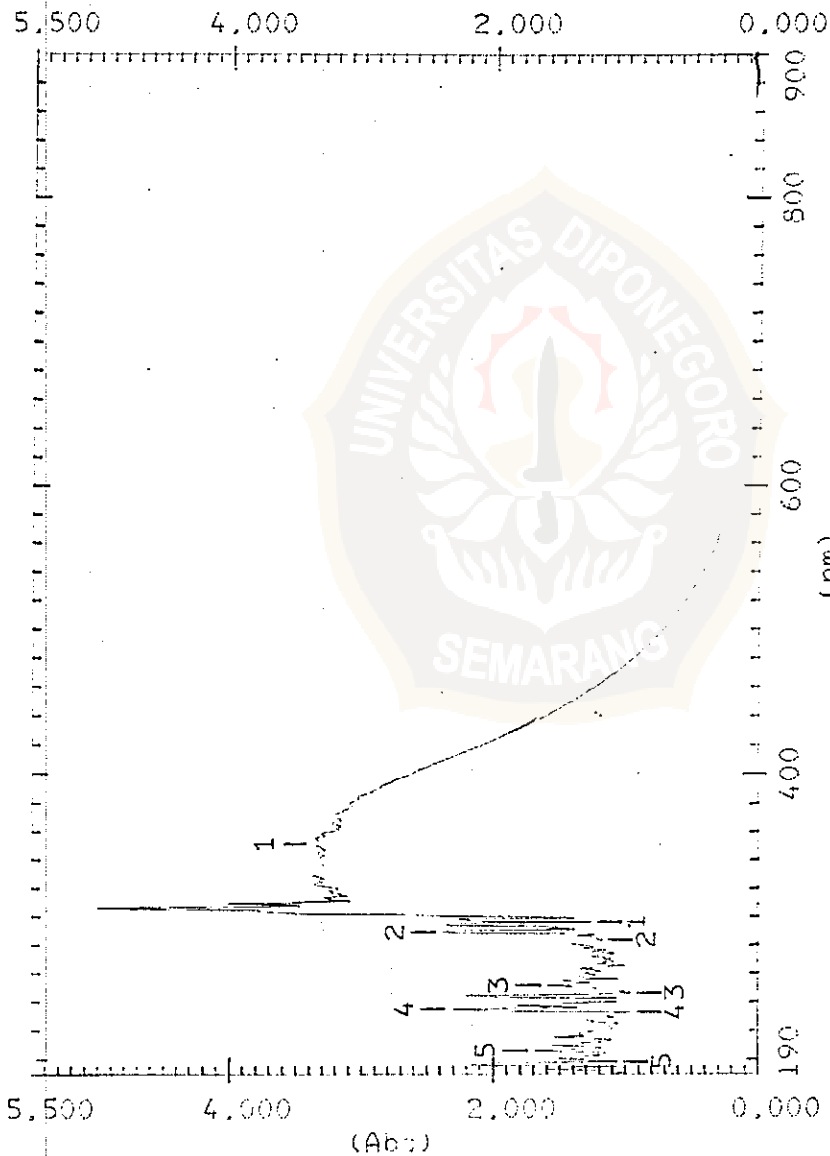


L A M P I R A N





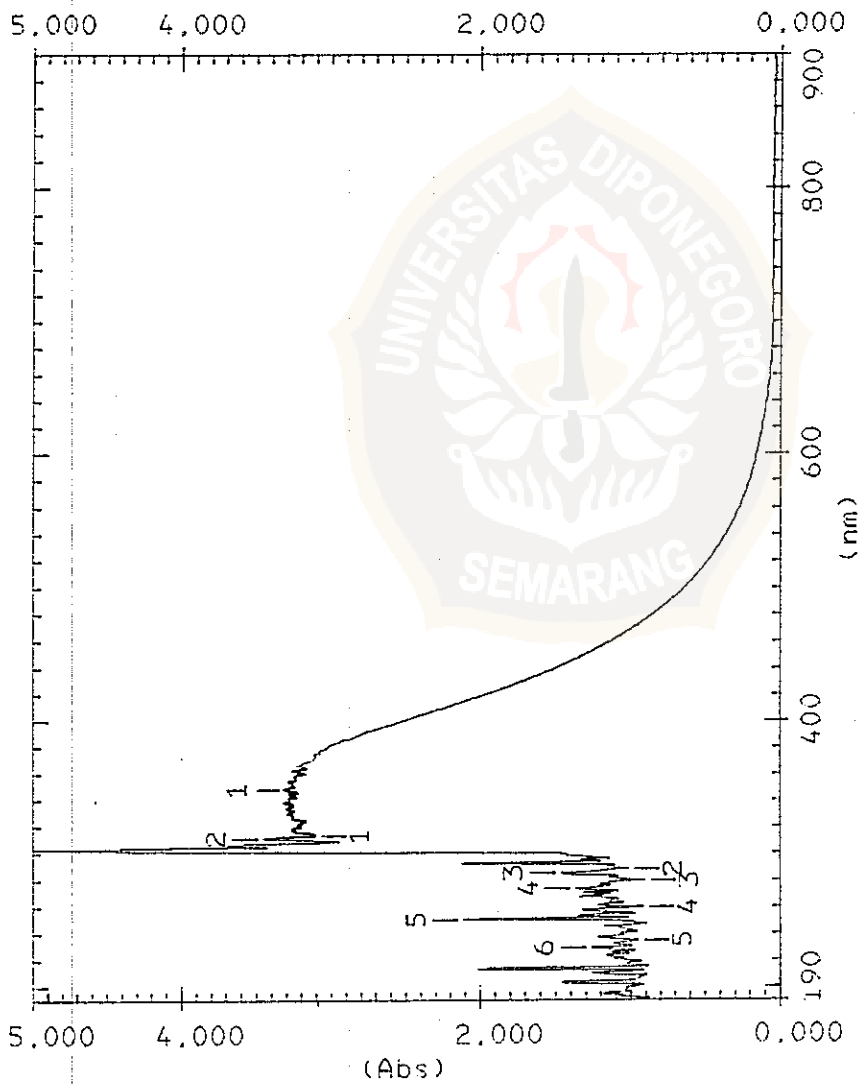
[PEAK]	[WAVELENGTH]	(ABS) VALUE	[VALLEY]	(ABS) VALUE
1:	351.5	3.373	1:	296.5
2:	289.0	2.382	2:	283.5
3:	251.5	1.597	3:	246.5
4:	235.0	2.315	4:	233.0
5:	206.5	1.693	5:	198.5

SAMPLE : **a-Si**
 CONC. :
 REFERENCE :
 PATHLENGTH :

SPEED : FAST
 DATE :
 SLIT : 2.0

ANALYST :

SI MLRNI 05

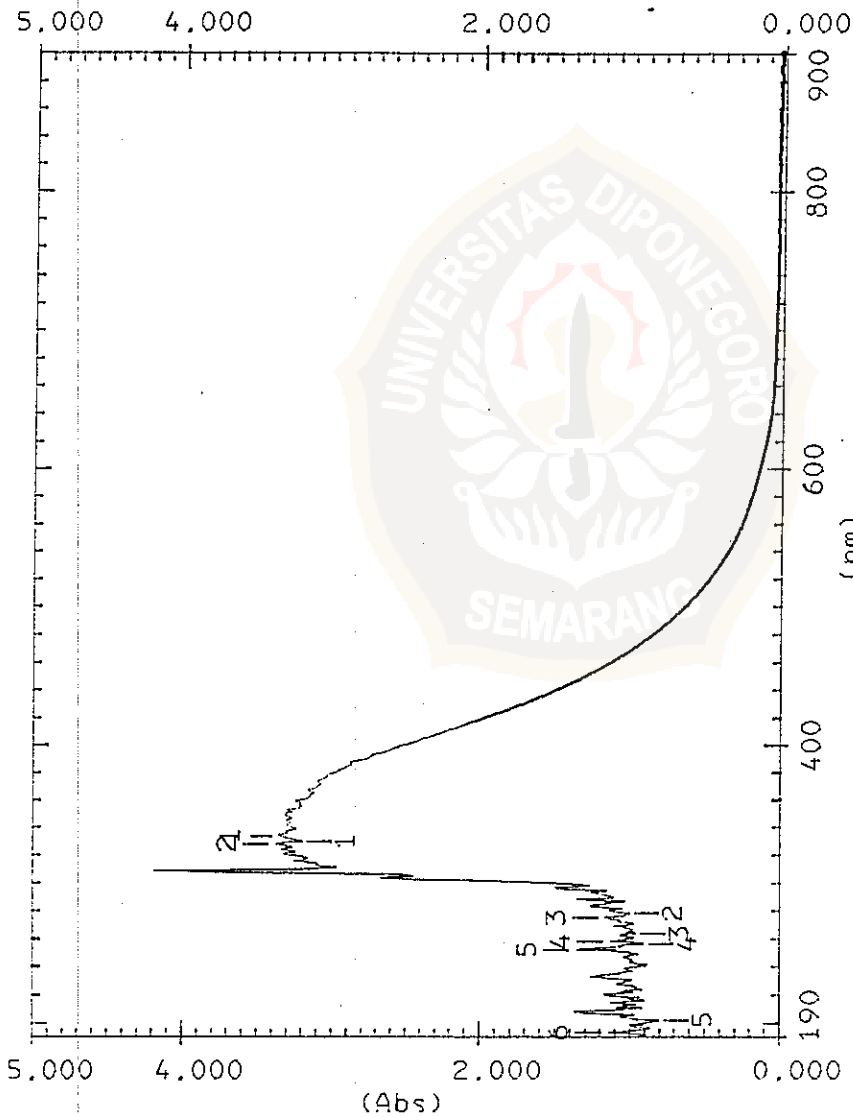


[PEAK]	(ABS) WAVELENGTH VALUE	[VALLEY] WAVELENGTH VALUE	(ABS) WAVELENGTH VALUE
1:	348.5	314.0	3.099
2:	311.5	288.5	1.010
3:	285.5	280.0	0.900
4:	274.0	260.0	0.908
5:	250.0	235.0	0.942
6:	229.0		

SAMPLE : a-Si, anil 200°C
CONC. :
REFERENCE :
PATHLENGTH :
COMMENT :

SPEED : FAST
DATE :
SLIT : 2.0

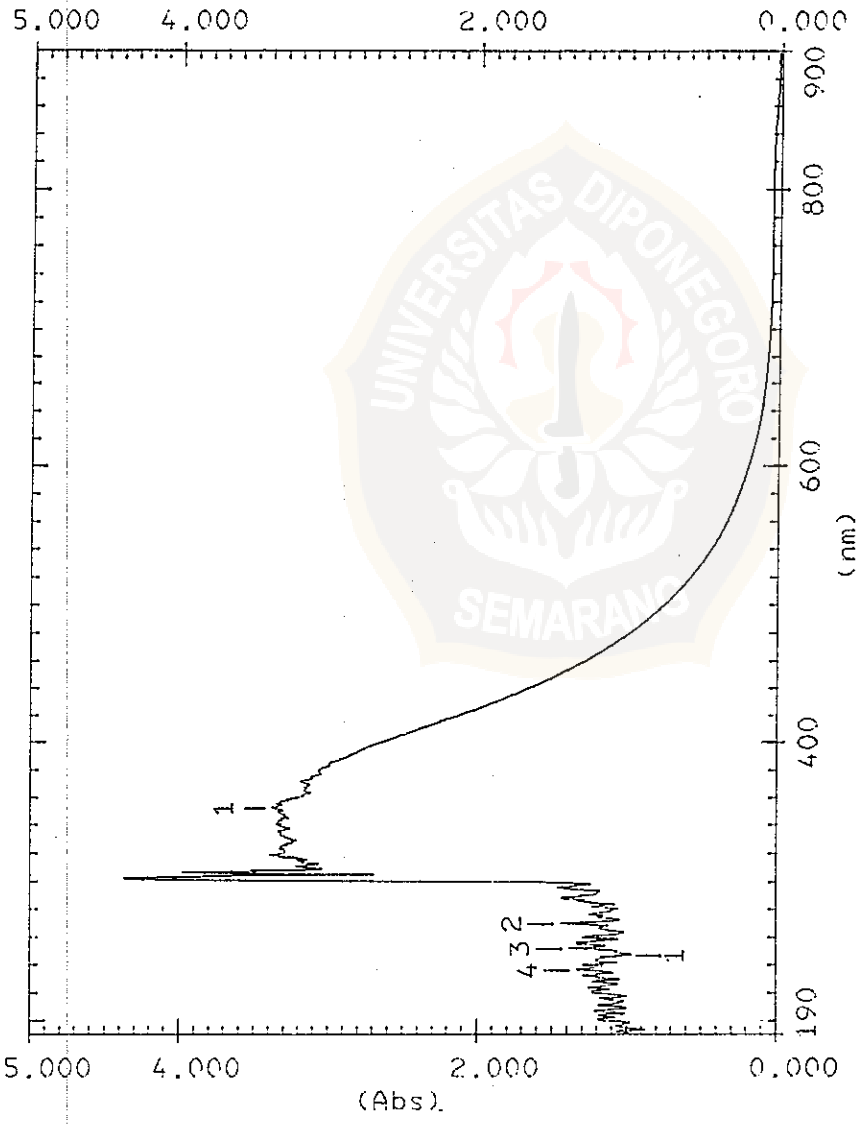
ANALYST :



[PEAK]	(ABS) WAVELENGTH VALUE	[VALLEY] WAVELENGTH VALUE	(ABS) WAVELENGTH VALUE
1:	333.5	330.0	3.191
2:	327.5	278.5	1.000
3:	275.0	263.5	0.956
4:	258.5	256.5	0.906
5:	252.5	202.0	0.796
6:	193.5	1.144	

SAMPLE : **a-Si, anil 300°C**
 CONC. :
 REFERENCE :
 PATHLENGTH :
 COMMENT :

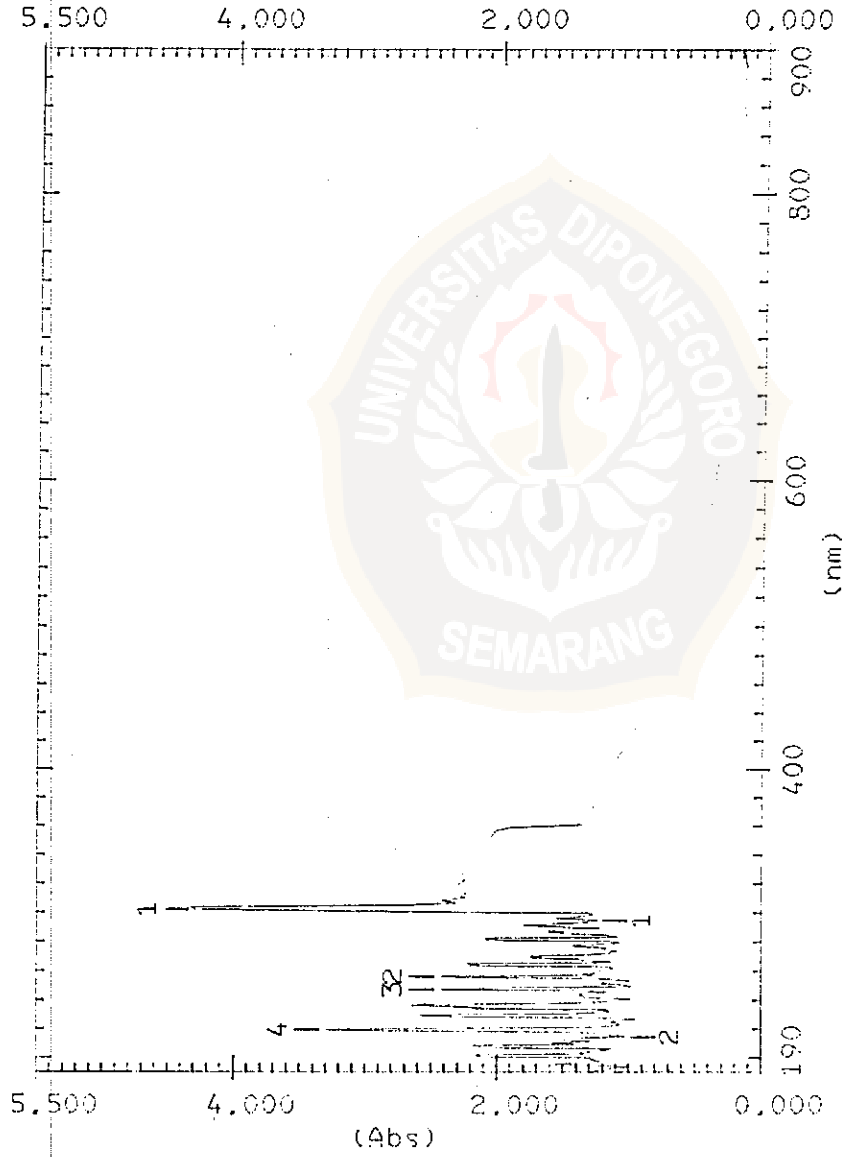
SPEED : FAST
 DATE :
 SLIT : 2.0
 ANALYST :



[PEAK]	(ABS) WAVELENGTH VALUE	[VALLEY] WAVELENGTH VALUE	(ABS) VALUE
1:	352.5	1: 247.5	0.964
2:	270.5		
3:	252.0		
4:	237.0		

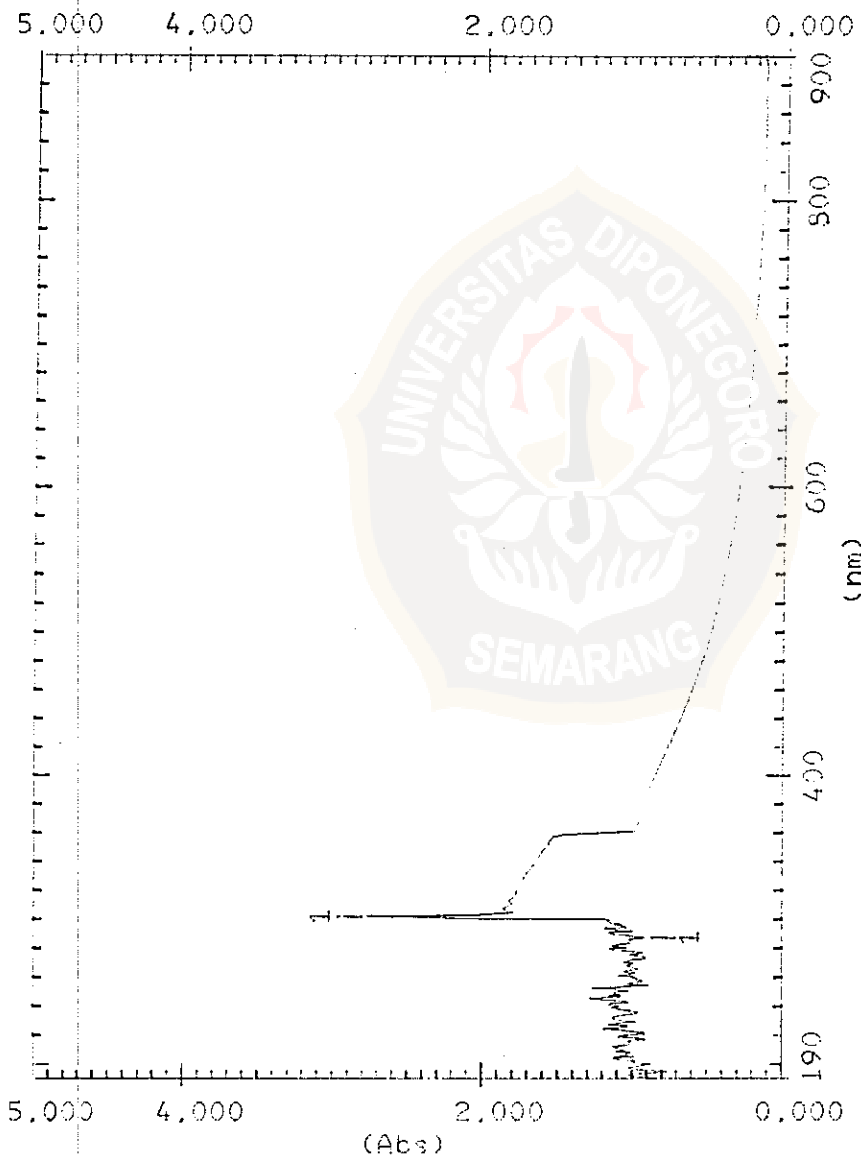
SAMPLE : **a-Si, anil 400°C**
 CONC. :
 REFERENCE :
 PATHLENGTH :
 SPEED : FAST
 DATE :
 SLIT : 2.0
 COMMENT :
 ANALYST :

[PEAK]	(ABS) WAVELENGTH VALUE	[VALLEY] WAVELENGTH VALUE	(ABS) WAVELENGTH VALUE
1:	302.0	4.299	1: 294.5
2:	256.5	2.428	2: 214.0
3:	247.5	2.427	
4:	219.5	3.306	



SAMPLE : **a-Si:H** ...
 CONC. :
 REFERENCE :
 PATHLENGTH :
 SPEED : FAST
 DATE :
 SLIT : 2.0
 ANALYST :

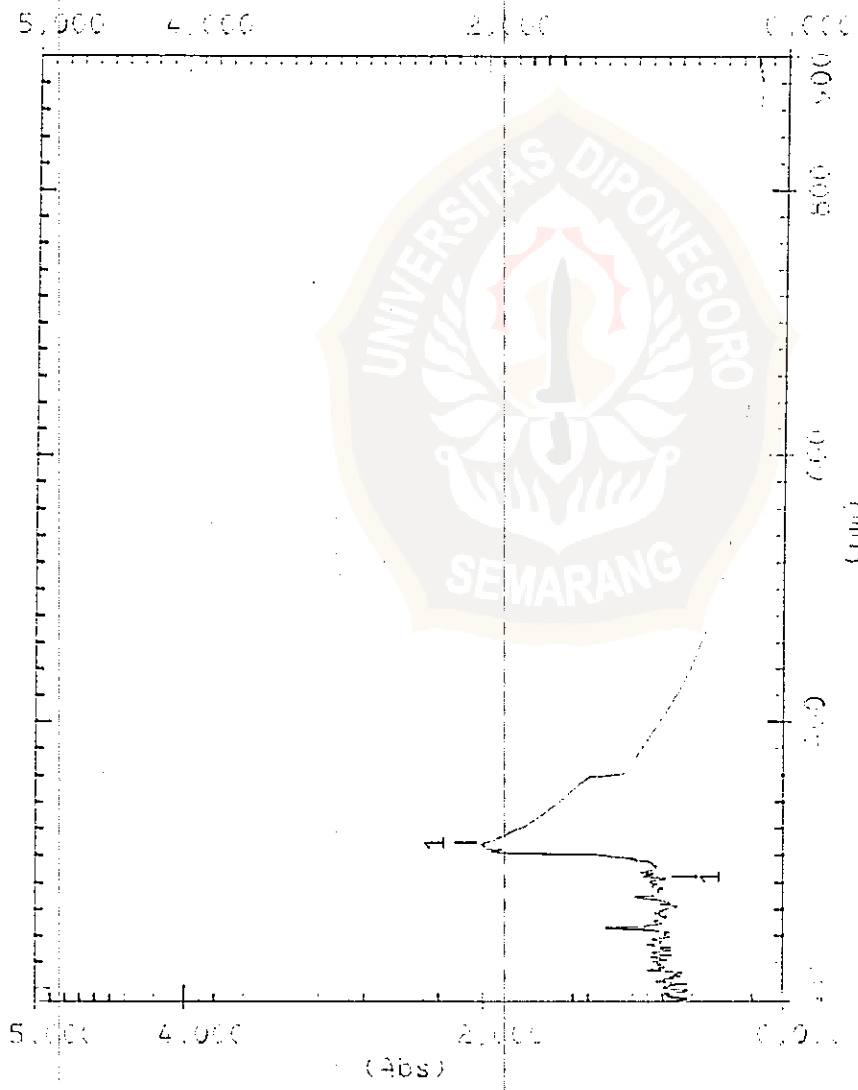
COMMENT :



[PEAK]	(ABS)	[VALLEY]	(ABS)
WAVELENGTH	VALUE	WAVELENGTH	VALUE

1:	302.0	2.771	1:	287.5	0.916
----	-------	-------	----	-------	-------

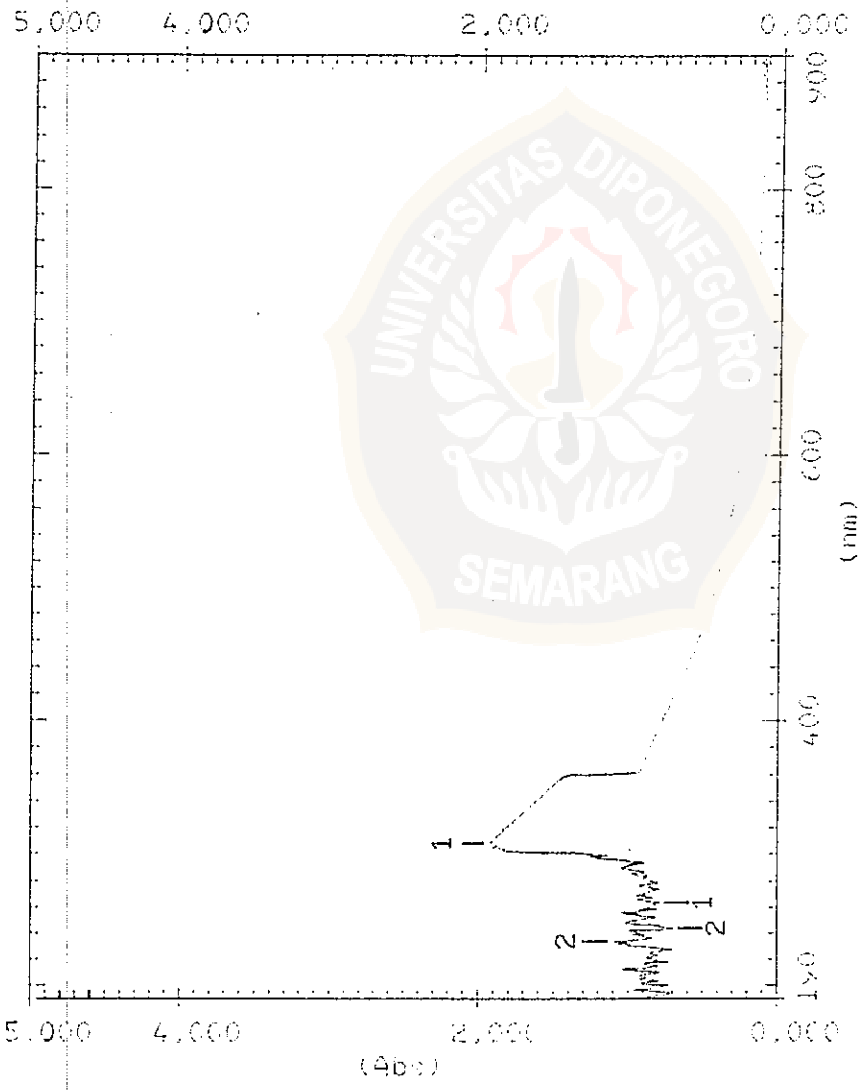
SAMPLE : **a-Si:H, anil 200°C**
 CONC. :
 REFERENCE :
 PATHLENGTH :
 SPEED : FAST
 DATE :
 SLIT : 2.0
 COMMENT :
 ANALYST :



[PEAK]	(ABS)	[VALLEY]	(ABS)
WAVELENGTH	VALUE	WAVELENGTH	VALUE
J: 308.0	2.015	J: 283.0	0.783

SAMPLE : a-Si:H, anil 300°C
 CONC :
 REFERENCE :
 PATHLENGTH :
 COMMENT :

SPEED : FAST
 DATE :
 SLIT : 2.0
 ANALYST :



[PEAK]	(ABS) WAVELENGTH	(ABS) VALUE	[VALLEY] WAVELENGTH	(ABS) VALUE	
1:	307.5	1.918	1:	263.0	0.786
2:	233.0	1.094	2:	243.5	0.697

SAMPLE : **a-Si:H, anil 400°C**
 CONC. :
 REFERENCE :
 PATHLENGTH :
 SPEED : FAST
 DATE :
 SLIT : 2.0
 ANALYST :